

AAEON

AAEON Technology INC.
ISO-9001/ISO-14001 Certified
Industrial Automation PCs

AEC-6200 EVT

Temperature Test Report

Release Date : Jun/22/2001

Issue Stamp

QA Manager

QE Manager

Test Engineer

Environment

Model Name : AEC-6200 EVT

Test Date : 06-22-2001

Test Site : AAEON QE Dept.

Performed by : Rex Chang

Test Standard :

Select	NO.	Description
√	IEC 68-2-61	Test Z/ABD : Climatic Sequence Test

Testing Item :

Temperature & Humidity Cycle

Additional Test Peripheral :

Configuration	Model
Test Software	Run QAPlus 5.5

Testing Equipment :

Programmable Temperature & Humidity Chamber

Model : Ths-D4L+-100

S/N : 1241

Date of Calibration : 07-10-1998

Sample Configuration & Quantity Under Test :

System Information :

Chassis :

AEC-6200

System : PCM-6896

1.Chipset: Intel 815E

2.CPU: Intel Pentium III 1GHz

3.Memory: 128M SDRAM (INFINEON HYB3956480 PC-133)

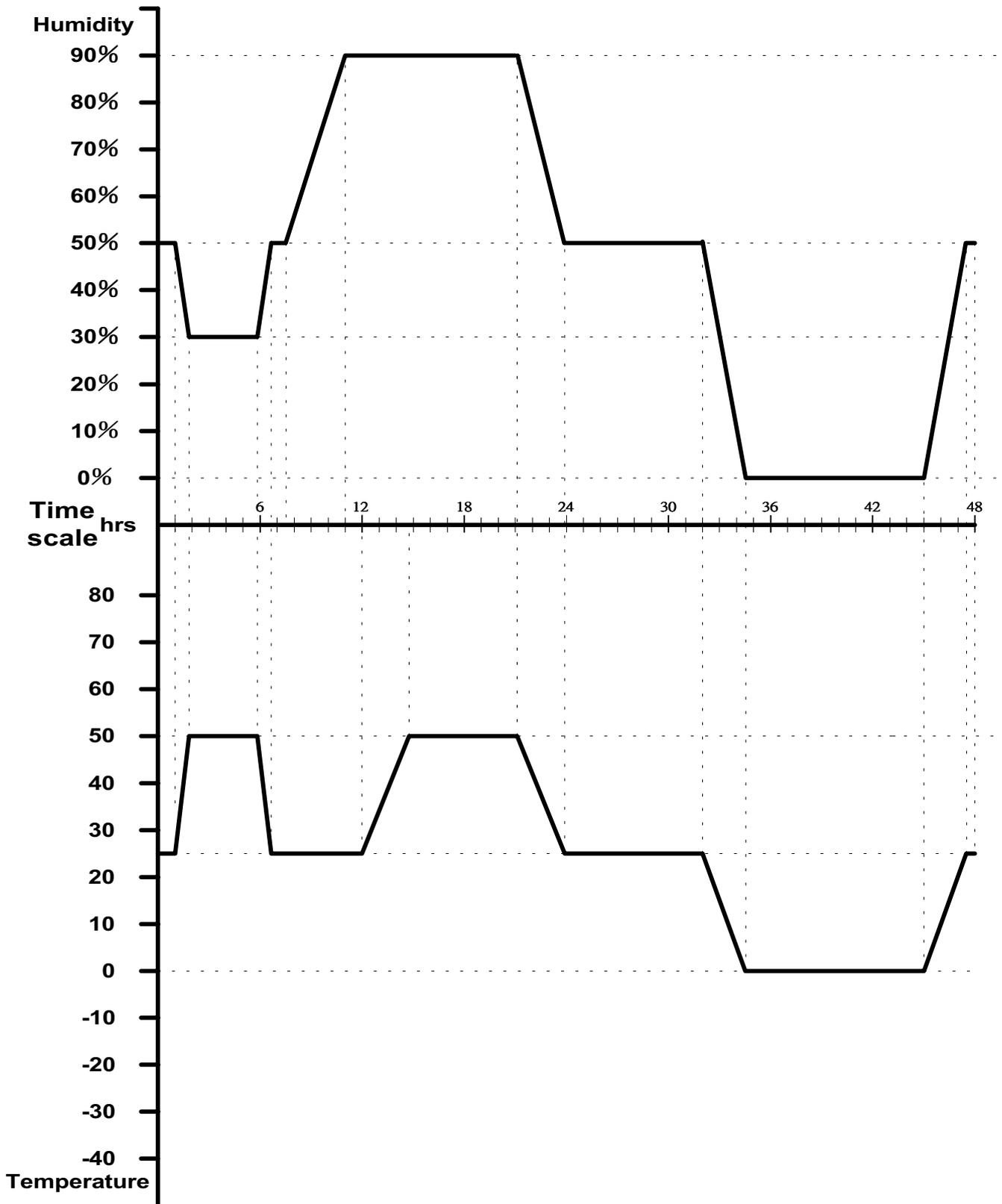
4.VGA: Intel 815E

Test Result :

Standard	Description	Result
IEC 68-2-61	Temperature & Humidity Cycle Test (Run QAPlusfe 5.5)	Pass

Environment

Temperature & Humidity Cycle Test(Run QAPlusfe 5.5)



Environment

Temperature & Humidity Cycle Test(Run QAPlusfe 5.5)

